

<b>Notice of References Cited</b>		Application/Control No. <b>09/824,980</b>	Applicant(s)/Patent Under Reexam <b>Williams et al.</b>	
		Examiner <b>Daniel G. DePumpo</b>	Art Unit <b>3611</b>	<b>Page 1 of 1</b>

**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	4,896,089	1/1990	Kliman et al.	318	701
B	6,329,782	12/2001	Chen et al.	318	727
C	6,266,591	7/2001	Wilson-Jones et al.	180	421
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**NON-PATENT DOCUMENTS**

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<sup>1</sup> Dates in MM-YYYY format are publication dates.

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